

<b>Notice of References Cited</b>	Application/Control No. 10/656,267	Applicant(s)/Patent Under Reexamination HIRAKATA ET AL.	
	Examiner Steven H. VerSteeg	Art Unit 1753	Page 1 of 1

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	B	US-2002/0179428 A1	12-2002	Anazawa et al.	204/173
	C	US-6,063,243	05-2000	Zetl et al.	204/164
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**NON-PATENT DOCUMENTS**

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